

Enhancement Mode N-Channel Power MOSFET

 $TO-263/NMOS/85V/\pm20V/3.0V/130A/4.4m\Omega$

Rev_{0.2}





85V, 4.4mΩ, 130A, N-Channel Enhancement MOSFET

1.Features

- ♦ 85V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V
- ♦ 100% RG Tested
- ◆ 100% UIS Tested

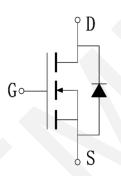
2.Applications

- Power Switching Application
- ◆ Load Switching



Pin Description

V_{DS} R_{DS(on)} Typ. I_D Max. 85V 4.4mΩ @ 10V 130A



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX044N09KF	044N09	TO-263	800	4,800

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	85	V
Gate to Source Voltage	V _{GSS}	±20	V
Drain Current (DC)	lο	130	А
Drain Current (Pulse), PW≤300μs	I _{DP}	520	А
Total Dissipation	P _D	125	W
Avalanche Energy, Single Pulsed	E _{AS}	338	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to Case	Rejc	1.0	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

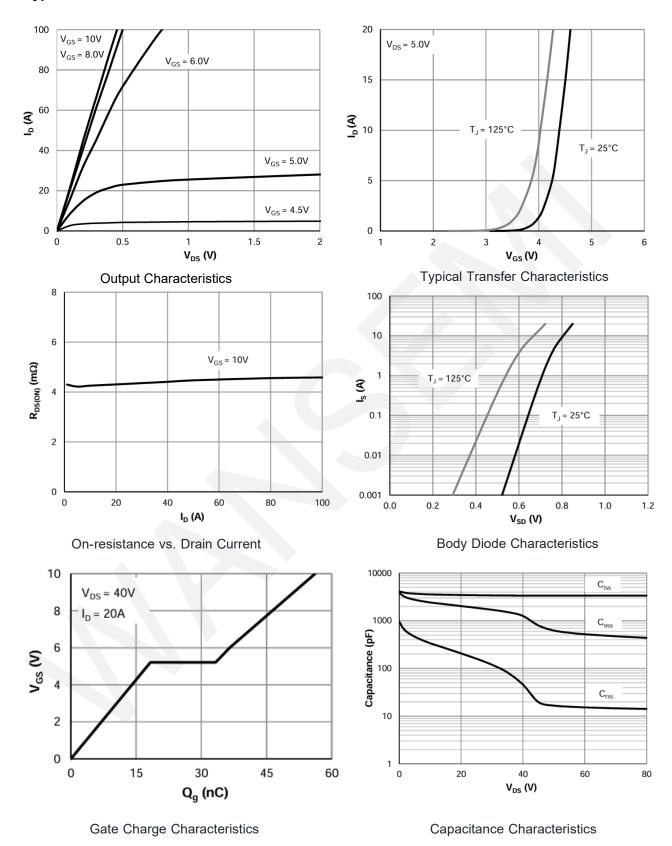
6.Electrical Characteristics at Ta=25°C (Note 3)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	85	-	-	V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80V, V _{GS} = 0V	-		1	μA
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V, V_{SS} = 0V$	1	-	±100	nA
Gate Threshold Voltage	$V_{\text{GS(th)}}$	V _{DS} =V _{GS} , I _{DS} =250µA	2.0	3.0	4.0	V
Static Drain to Source On-State Resistance	R _{DS(on)}	I _D = 20A, V _{GS} = 10V	1	4.4	5.5	mΩ
Input Capacitance	Ciss	V _{GS} =0V,	-	3365	-	nF
Output Capacitance	Coss	V _{DS} =40V, Frequency=1.0MHz	-	1264	-	pF
Reverse Transfer Capacitance	Crss		-	46	-	pF
Turn-ON Delay Time	t _{d(on)}	$V_{DD}=40V,$ $V_{GS}=10V,$ $R_{GEN}=3\Omega, \ R_{L}=2.0\Omega$	1	17.6	-	ns
Rise Time	t _r		1	27	-	ns
Turn-OFF Delay Time	$t_{\text{d(off)}}$		ı	31	-	ns
Fall Time	t _f		ı	10.8	-	ns
	Q_g	$V_{DS} = 40V,$ $V_{GS} = 0 \text{ to } 10V,$ $I_{D} = 20A$	ı	56	-	nC
Total Gate Charge	Q_{gs}		-	18.3	-	nC
	Q _{gd}		-	15	-	nC
Diode Forward Voltage	V _{FSD}	I _S = 20A, V _{GS} = 0	0.5	-	1.2	V

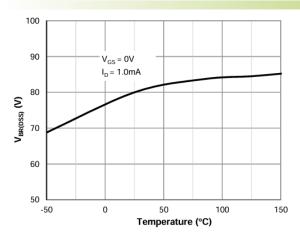
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



7. Typical electrical and thermal characteristics







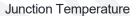
1.6 V_{GS} = 10V I_D = 20A V_{GS} =

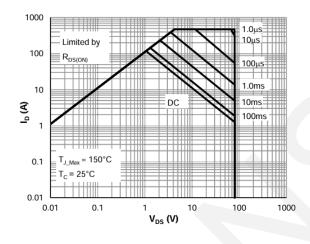
2.0

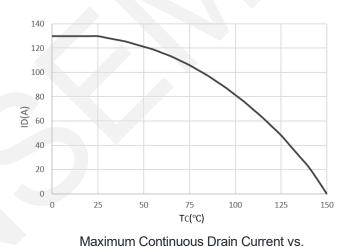
Normalized Breakdown Voltage vs.

Junction Temperature

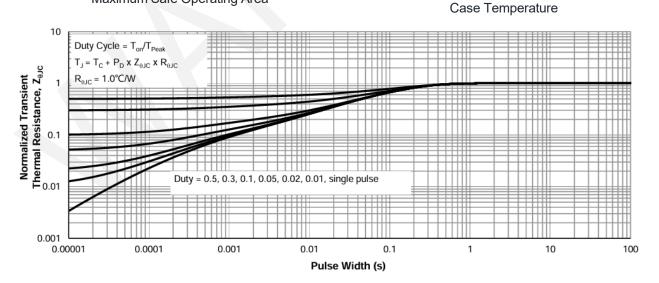
Normalized on Resistance vs.







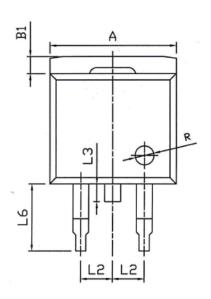
Maximum Safe Operating Area

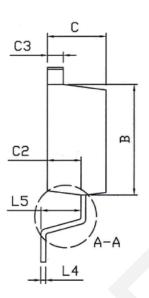


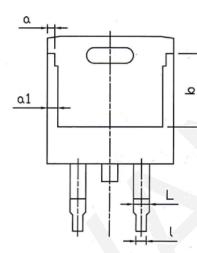
Maximum Effective Transient Thermal Impedance, Junction-to-Case



8.Package Dimensions









Dimensions In Millimeters					
Symbol	MIN	TYP	MAX		
Α	10.00	10.20	10.40		
В	8.50	8.70	8.90		
B1	1.06	1.26	1.46		
С	4.49	4.69	4.89		
C5	2.54	2.69	2.84		
C3	1.17	1.27	1.37		
L	1.12	1.27	1.42		
L1	2.34	2.54	2.74		
L2	ı	2.54	_		
L3	1.20	1.40	1.60		
L4	0.281	0.381	0.481		
L5	2.54	2.79	3.04		
L6	5.05	5.30	5,55		
R	1	1.50	-		
a	0.455	0.655	0.855		
a1	0.70	0.90	1.10		
b	5.648	5.798	5.948		
k	0.00	-	0.25		
. L .	0.70	0.81	0.96		
θ	0°	-	9°		



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